


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552335	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, SANG-YUP
	<b>Examiner</b>  Durham, Nathan E	<b>Art Unit</b>  3765

SEARCHED			
Class	Subclass	Date	Examiner
223	85,88,89,92,94,95	10/25/2006	NED
206	278,279,282,284,285,300	10/24/2006	NED
D6	315,318,319	10/25/2006	NED
211	85.3	10/25/2006	NED
Updated class search		03/12/2007	NED
206	288,289,,299	03/12/2007	NED
223	DIG.4	03/12/2007	NED

SEARCH NOTES		
Search Notes	Date	Examiner
See attached EAST search	10/24/2006	NED
Updated EAST search	03/12/2007	NED
Consulted SPE, Gary Welch	03/15/2007	NED

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner